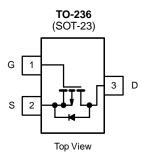


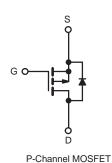
AM2381P-VB Datasheet P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	- 60						
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	0.05					
Q _g (Max.) (nC)	12						
Q _{gs} (nC)	3.8						
Q _{gd} (nC)	5.1						
Configuration	Single						

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted SYMBOL PARAMETER LIMIT UNIT **Drain-Source Voltage** - 60 V_{DS} V Gate-Source Voltage V_{GS} ± 20 T_C = 25 °C - 5.2 V_{GS} at - 10 V **Continuous Drain Current** I_D $T_{\rm C} = 100 \,^{\circ}{\rm C}$ - 3.8 А Pulsed Drain Currenta - 21 **I**_{DM} Linear Derating Factor W/°C 0.18 Single Pulse Avalanche Energy^b E_{AS} 120 mJ Repetitive Avalanche Current^a - 5.2 А I_{AR} Repetitive Avalanche Energy^a 2.7 E_{AR} mJ Maximum Power Dissipation T_C = 25 °C 27 W P_D Peak Diode Recovery dV/dtc dV/dt - 4.5 V/ns Operating Junction and Storage Temperature Range T_J, T_{sta} - 55 to + 175 °C Soldering Recommendations (Peak Temperature) for 10 s 300^d lbf · in 10 Mounting Torque 6-32 or M3 screw 1.1 N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 5.0 mH, $R_G = 25 \Omega$, $I_{AS} = -5.3 \text{ A}$ (see fig. 12). c. $I_{SD} \leq -6.7 \text{ A}$, dl/dt $\leq 90 \text{ A/}\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.

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PARAMETER	SYMBOL	TYP	·	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 65			°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 5.5						
SPECIFICATIONS T _J = 25 °C, u	unless other	wise noted						
PARAMETER	SYMBOL	TEST CONDITIONS		NS	MIN.	TYP.	MAX.	UNI
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA		- 60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I _D	= - 1 mA	-	- 0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = -250 \mu A$		- 1.0	-	- 2.5	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	-	± 100	nA
	000	V _{DS} = - 60 V, V _{GS} = 0 V		-	-	- 100		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = - 48	$V_{DS} = -48 V_{GS} = 0 V, T_J = 150 °C$		-	-	- 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D =	- 3.2 A ^b	-	0.05	-	Ω
Forward Transconductance		V _{DS} =	- 25 V, I _D = -	3.2 A ^b	1.6	-	-	S
Dynamic								
Input Capacitance	Ciss	V _{GS} = 0 V, V _{DS} = - 25 V, f = 1.0 MHz, see fig. 5		-	270	-	pF	
Output Capacitance	C _{oss}			-	170	-		
Reverse Transfer Capacitance	C _{rss}			-	31	-		
Drain to Sink Capacitance	С		f = 1.0 MHz		-	12	-	1
Total Gate Charge	Qg			-	-	12	1	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$I_D = -4.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13^{b}		-	-	3.8	nC
Gate-Drain Charge	Q _{gd}				-	-	5.1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = -30 \text{ V}, \text{ I}_{D} = -4.7 \text{ A}, \\ \text{R}_{G} = 24 \Omega, \text{ R}_{D} = 4.0 \Omega, \\ \text{see fig. } 10^{\text{b}}$		-	11	-	- ns	
Rise Time	tr			-	63	-		
Turn-Off Delay Time	t _{d(off)}			-	9.6	-		
Fall Time	t _f			-	31	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	Ls			-	7.5	-		
Drain-Source Body Diode Characteristic	s				•			
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 5.2	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 21		
Body Diode Voltage	V_{SD}	$T_J = 25 \text{ °C}, I_S = -5.2 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	- 5 .5	V	
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 4.7 A, dl/dt = 100 A/µs ^b		-	80	160	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.096	0.19	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					loand	5)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

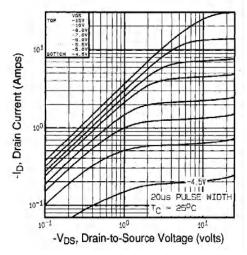


Fig. 1 - Typical Output Characteristics, T_C= 25 °C

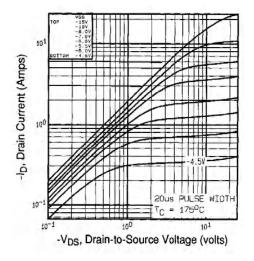


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

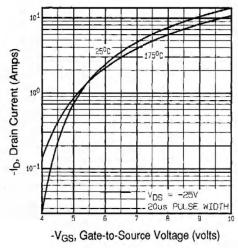


Fig. 3 - Typical Transfer Characteristics

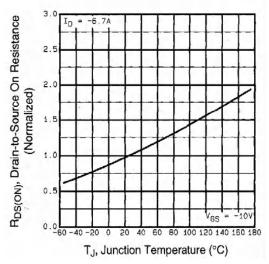


Fig. 4 - Normalized On-Resistance vs. Temperature



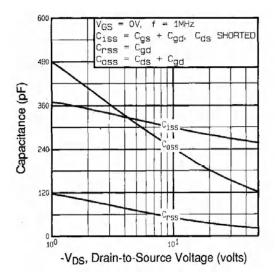
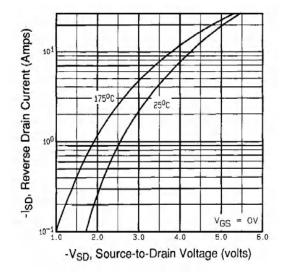
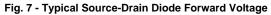


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





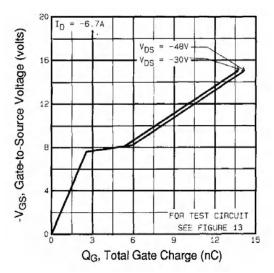
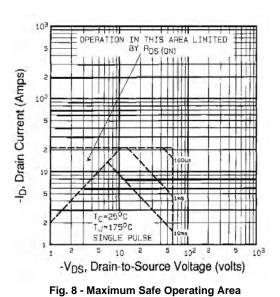


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





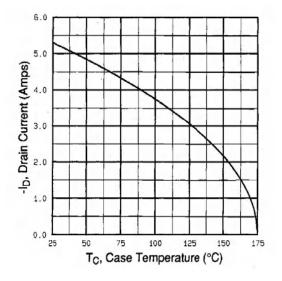


Fig. 9 - Maximum Drain Current vs. Case Temperature

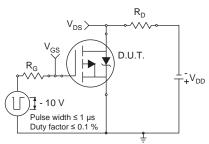


Fig. 10a - Switching Time Test Circuit

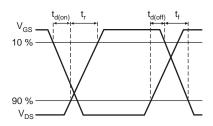
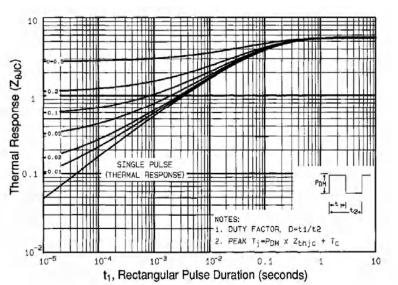
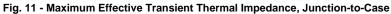


Fig. 10b - Switching Time Waveforms





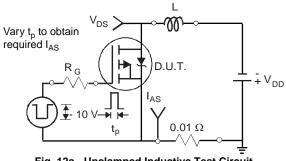


Fig. 12a - Unclamped Inductive Test Circuit

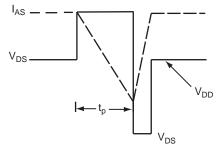
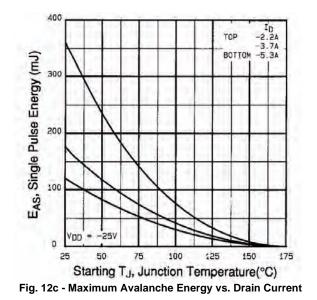
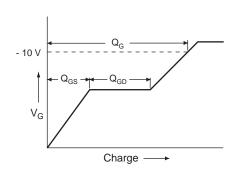


Fig. 12b - Unclamped Inductive Waveforms







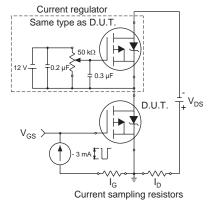
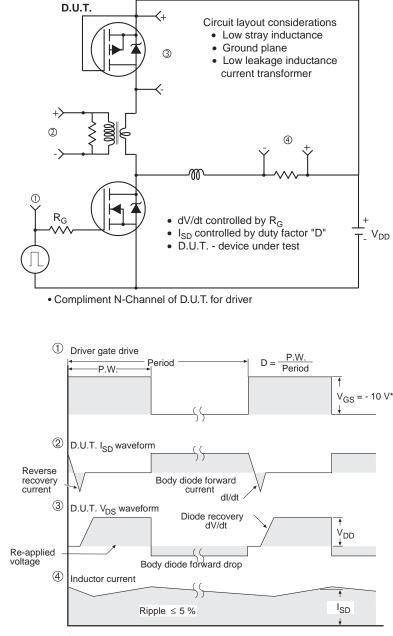


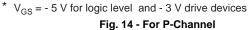
Fig. 13a - Basic Gate Charge Waveform

Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit





SOT-23 (TO-236): 3-LEAD



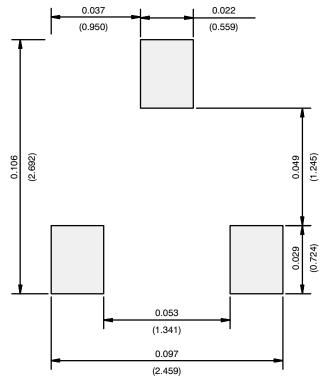




Dim	MILLI	METERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
q ECN: S-03946-Rev. K, 09- DWG: 5479	÷	8°	3°	8°	



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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